

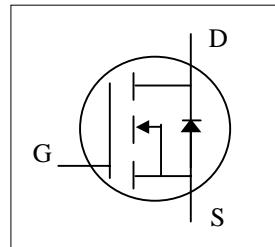
AP60SL600AIN
Halogen-Free Product



**Advanced Power
Electronics Corp.**

**N-CHANNEL ENHANCEMENT MODE
POWER MOSFET**

- ▼ 100% R_g & UIS Test
- ▼ Fast Switching Characteristic
- ▼ Simple Drive Requirement
- ▼ RoHS Compliant & Halogen-Free

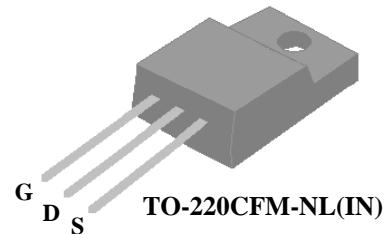


$V_{DS} @ T_{j,max.}$	650V
$R_{DS(ON)}$	0.6Ω
$I_D^{3,4}$	7A

Description

AP60SL600A series are from Advanced Power innovative design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The TO-220CFM package is widely preferred for all commercial-industrial through hole applications. The mold compound provides a high isolation voltage capability and low thermal resistance between the tab and the external heat-sink.



Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	600	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_c=25^\circ\text{C}$	Drain Current, $V_{GS} @ 10\text{V}^{3,4}$	7	A
$I_D @ T_c=100^\circ\text{C}$	Drain Current, $V_{GS} @ 10\text{V}^{3,4}$	4.4	A
I_{DM}	Pulsed Drain Current ¹	18	A
dv/dt	MOSFET dv/dt Ruggedness ($V_{DS} = 0 \dots 400\text{V}$)	50	V/ns
$P_D @ T_c=25^\circ\text{C}$	Total Power Dissipation	26	W
$P_D @ T_A=25^\circ\text{C}$	Total Power Dissipation	1.92	W
E_{AS}	Single Pulse Avalanche Energy ⁵	36.7	mJ
dv/dt	Peak Diode Recovery dv/dt^6	15	V/ns
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Value	Units
R_{thj-c}	Maximum Thermal Resistance, Junction-case	4.8	°C/W
R_{thj-a}	Maximum Thermal Resistance, Junction-ambient	65	°C/W



Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	600	-	-	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=2\text{A}$	-	-	0.6	Ω
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$	2	-	5	V
g_{fs}	Forward Transconductance	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_D=2\text{A}$	-	5	-	S
I_{DSS}	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=480\text{V}, \text{V}_{\text{GS}}=0\text{V}$	-	-	100	μA
I_{GSS}	Gate-Source Leakage	$\text{V}_{\text{GS}}=\pm 20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Q_{g}	Total Gate Charge	$\text{I}_D=2\text{A}$	-	18	28.8	nC
Q_{gs}	Gate-Source Charge	$\text{V}_{\text{DS}}=480\text{V}$	-	4.5	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$\text{V}_{\text{GS}}=10\text{V}$	-	8	-	nC
$t_{\text{d(on)}}$	Turn-on Delay Time	$\text{V}_{\text{DD}}=300\text{V}$	-	7	-	ns
t_r	Rise Time	$\text{I}_D=2\text{A}$	-	20	-	ns
$t_{\text{d(off)}}$	Turn-off Delay Time	$\text{R}_G=3.3\Omega$	-	26	-	ns
t_f	Fall Time	$\text{V}_{\text{GS}}=10\text{V}$	-	22	-	ns
C_{iss}	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}$	-	630	1008	pF
C_{oss}	Output Capacitance	$\text{V}_{\text{DS}}=100\text{V}$	-	27	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	3	-	pF
R_{g}	Gate Resistance	f=1.0MHz	-	4.3	8.6	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$\text{I}_S=2\text{A}, \text{V}_{\text{GS}}=0\text{V}$	-	0.8	-	V
t_{rr}	Reverse Recovery Time	$\text{I}_S=7\text{A}, \text{V}_{\text{GS}}=0\text{V}$	-	280	-	ns
Q_{rr}	Reverse Recovery Charge	dl/dt=50A/ μs	-	1.8	-	μC

Notes:

- 1.Pulse width limited by max. junction temperature.
- 2.Pulse test
- 3.Limited by max. junction temperature. Maximum duty cycle D=0.75
- 4.Ensure that the junction temperature does not exceed $T_{\text{Jmax.}}$
- 5.Starting $T_j=25^\circ\text{C}$, $\text{V}_{\text{DD}}=50\text{V}$, $L=150\text{mH}$, $\text{R}_G=25\Omega$
6. $\text{I}_{\text{SD}} \leq \text{I}_D$, $\text{V}_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, starting $T_j = 25^\circ\text{C}$

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

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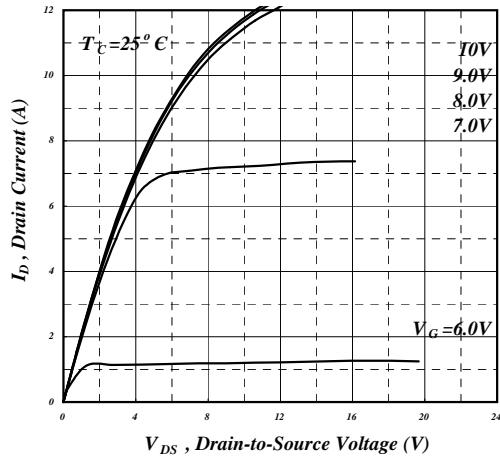


Fig 1. Typical Output Characteristics

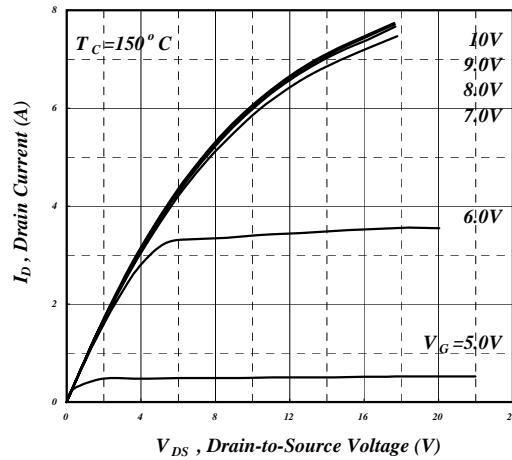


Fig 2. Typical Output Characteristics

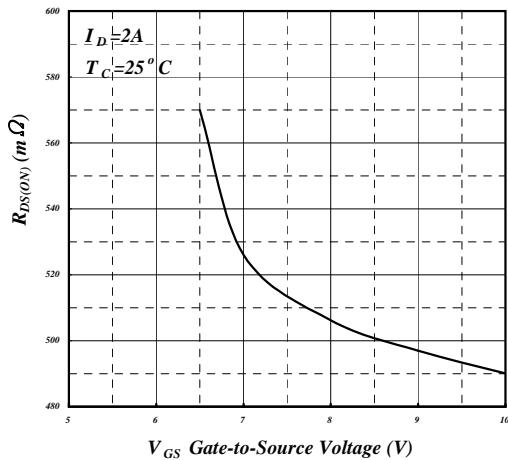


Fig 3. On-Resistance v.s. Gate Voltage

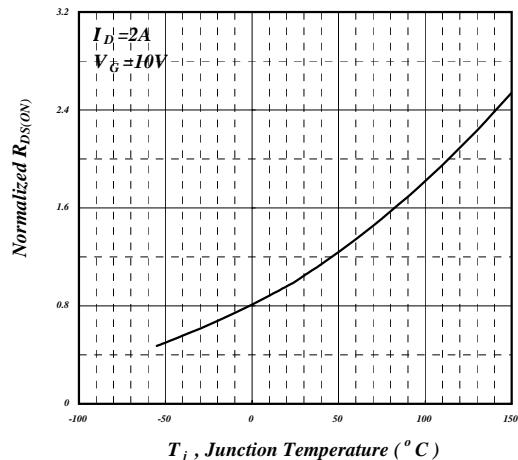


Fig 4. Normalized On-Resistance v.s. Junction Temperature

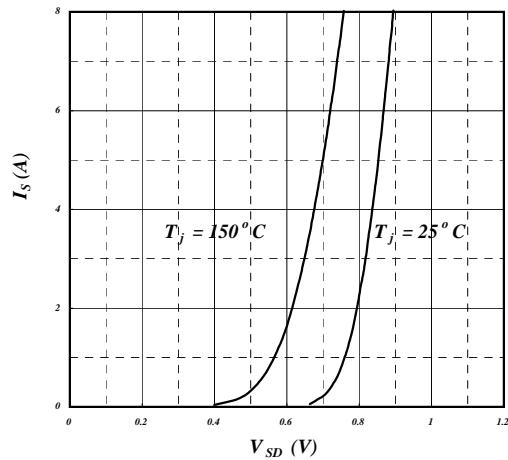


Fig 5. Forward Characteristic of Reverse Diode

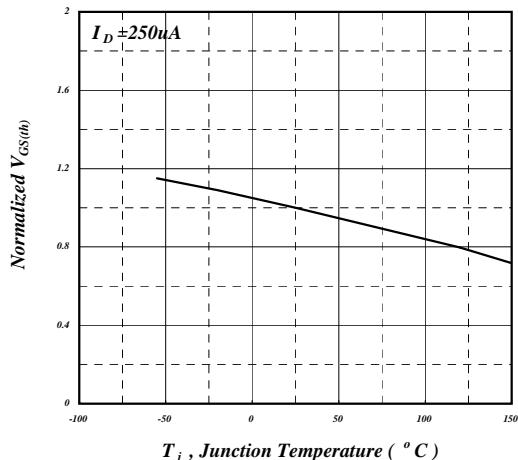
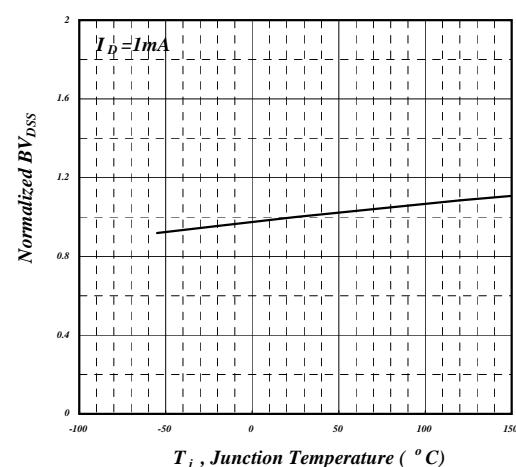
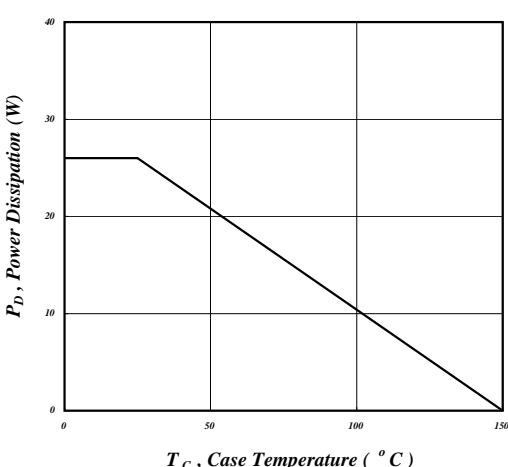
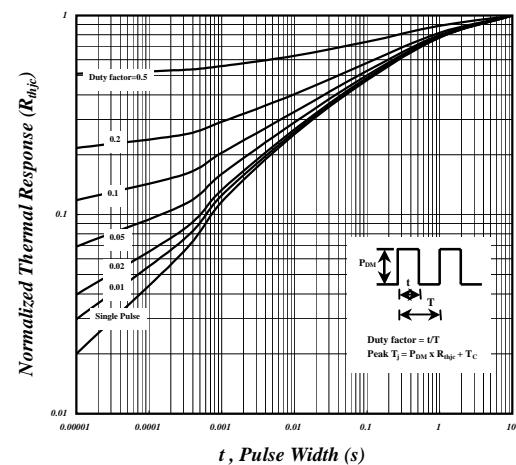
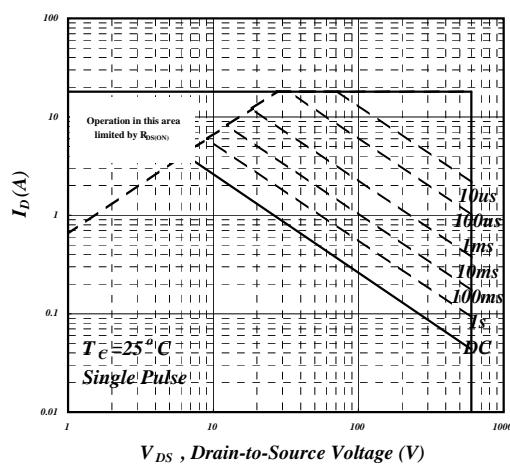
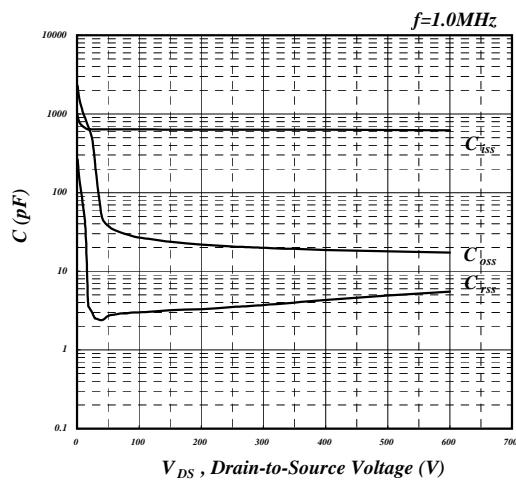
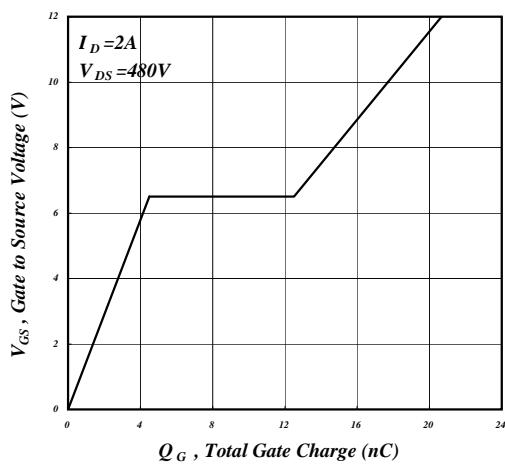


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

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MARKING INFORMATION

